

# WM3A040065Y

## N-Channel SiC Power MOSFET

### G3 MOSFET Technology

|                   |   |     |    |
|-------------------|---|-----|----|
| $V_{DS}$          | = | 650 | V  |
| $R_{DS(on)}$      | = | 40  | mΩ |
| $I_D@25^{\circ}C$ | = | 52  | A  |

#### Features

- High Blocking Voltage with Low On-Resistance
- High Speed Switching with Low Capacitance
- Easy to Parallel and Simple to Drive

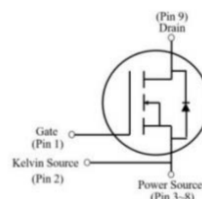
#### Benefits

- Higher System Efficiency
- Reduced Cooling Requirements
- Increased Power Density
- Increased System Switching Frequency

#### Applications

- Renewable Energy
- EV Battery Chargers
- High Voltage DC/DC Converters
- Switch Mode Power Supplies

#### Package



| Part Number | Package | Marking     |
|-------------|---------|-------------|
| WM3A040065Y | TOLL    | WM3A040065Y |

#### Maximum Ratings ( $T_c=25^{\circ}C$ unless otherwise specified)

| Symbol         | Parameter                                   | Value       | Unit        | Test Conditions                         | Note   |
|----------------|---------------------------------------------|-------------|-------------|-----------------------------------------|--------|
| $V_{DSmax}$    | Drain-Source Voltage                        | 650         | V           | $V_{GS}=0V, I_D=100\mu A$               |        |
| $V_{GSmax}$    | Gate-Source Voltage                         | -10/+23     | V           | Absolute maximum values                 |        |
| $V_{GSop}$     | Gate-Source Voltage                         | -5/+18      | V           | Recommended operational values          |        |
| $I_D$          | Continuous Drain Current                    | 52          | A           | $V_{GS}=18V, T_c=25^{\circ}C$           | Fig.19 |
|                |                                             | 37          |             | $V_{GS}=18V, T_c=100^{\circ}C$          |        |
| $I_{D(pulse)}$ | Pulsed Drain Current                        | 153         | A           | Pulse width $t_p$ limited by $T_{Jmax}$ | Fig.22 |
| $P_D$          | Power Dissipation                           | 187.5       | W           | $T_c=25^{\circ}C, T_J=175^{\circ}C$     | Fig.20 |
| $T_J, T_{STG}$ | Operating Junction and Storage Temperature  | -55 to +175 | $^{\circ}C$ |                                         |        |
| $T_L$          | Solder Temperature, 1.6mm from case for 10s | 260         | $^{\circ}C$ |                                         |        |
| $M_d$          | Mounting Torque, (M3 or 6-32 screw)         | 1           | Nm          |                                         |        |
|                |                                             | 8.8         | lbf-in      |                                         |        |

**Electrical Characteristics** ( $T_c=25^{\circ}\text{C}$  unless otherwise specified)

| Symbol        | Parameter                        | Min. | Typ. | Max. | Unit       | Test Conditions                                                                | Note       |
|---------------|----------------------------------|------|------|------|------------|--------------------------------------------------------------------------------|------------|
| $V_{(BR)DSS}$ | Drain-Source Breakdown Voltage   | 650  | /    | /    | V          | $V_{GS}=0V, I_D=1mA$                                                           |            |
| $V_{GS(th)}$  | Gate Threshold Voltage           | 2.0  | 2.9  | 4.0  | V          | $V_{DS}=V_{GS}, I_D=7.5mA$                                                     | Fig. 11    |
|               |                                  | /    | 2.1  | /    |            | $V_{DS}=V_{GS}, I_D=7.5mA, T_J=175^{\circ}\text{C}$                            |            |
| $I_{DSS}$     | Zero Gate Voltage Drain Current  | /    | 1    | 100  | $\mu A$    | $V_{DS}=650V, V_{GS}=0V$                                                       |            |
| $I_{GSS+}$    | Gate-Source Leakage Current      | /    | 10   | 100  | nA         | $V_{DS}=0V, V_{GS}=23V$                                                        |            |
| $I_{GSS-}$    | Gate-Source Leakage Current      | /    | 10   | 100  | nA         | $V_{DS}=0V, V_{GS}=-10V$                                                       |            |
| $R_{DS(on)}$  | Drain-Source On-State Resistance | /    | 40   | 52   | m $\Omega$ | $V_{GS}=18V, I_D=20A$                                                          | Fig. 4,5,6 |
|               |                                  | /    | 48   | /    | m $\Omega$ | $V_{GS}=18V, I_D=20A, T_J=175^{\circ}\text{C}$                                 |            |
| $g_{fs}$      | Transconductance                 | /    | 22   | /    | S          | $V_{DS}=20V, I_{DS}=20A$                                                       | Fig. 7     |
|               |                                  | /    | 20   | /    |            | $V_{DS}=20V, I_{DS}=20A, T_J=175^{\circ}\text{C}$                              |            |
| $C_{iss}$     | Input Capacitance                | /    | 1305 | /    | pF         | $V_{GS}=0V$                                                                    | Fig. 17,18 |
| $C_{oss}$     | Output Capacitance               | /    | 109  | /    |            | $V_{DS}=400V$                                                                  |            |
| $C_{rss}$     | Reverse Transfer Capacitance     | /    | 4.9  | /    |            | $f=1MHz$                                                                       |            |
| $E_{oss}$     | $C_{oss}$ Stored Energy          | /    | 9    | /    | $\mu J$    | $V_{AC}=25mV$                                                                  | Fig. 16    |
| $E_{ON}$      | Turn-On Switching Energy         | /    | 71   | /    | $\mu J$    | $V_{DS}=400V, V_{GS}=-5V/18V$                                                  |            |
| $E_{OFF}$     | Turn-Off Switching Energy        | /    | 69   | /    |            | $I_D=20A, R_{G(ext)}=2.5\Omega, L=100\mu H$                                    |            |
| $t_{d(on)}$   | Turn-On Delay Time               | /    | 6    | /    | ns         | $V_{DS}=400V, V_{GS}=-5V/18V, I_D=20A$<br>$R_{G(ext)}=2.5\Omega, R_L=20\Omega$ |            |
| $t_r$         | Rise Time                        | /    | 8    | /    |            |                                                                                |            |
| $t_{d(off)}$  | Turn-Off Delay Time              | /    | 15   | /    |            |                                                                                |            |
| $t_f$         | Fall Time                        | /    | 5    | /    |            |                                                                                |            |
| $R_{G(int)}$  | Internal Gate Resistance         | /    | 2.0  | /    | $\Omega$   | $f=1MHz, V_{AC}=25mV$                                                          |            |
| $Q_{GS}$      | Gate to Source Charge            | /    | 14   | /    | nC         | $V_{DS}=400V$                                                                  | Fig. 12    |
| $Q_{GD}$      | Gate to Drain Charge             | /    | 12   | /    |            | $V_{GS}=-5V/18V$                                                               |            |
| $Q_G$         | Total Gate Charge                | /    | 40   | /    |            | $I_D=20A$                                                                      |            |

**Reverse Diode Characteristics**

| Symbol    | Parameter                        | Typ. | Max. | Unit | Test Conditions                                   | Note        |
|-----------|----------------------------------|------|------|------|---------------------------------------------------|-------------|
| $V_{SD}$  | Diode Forward Voltage            | 3.9  | /    | V    | $V_{GS}=-5V, I_{SD}=10A, T_J=25^{\circ}\text{C}$  | Fig. 8,9,10 |
|           |                                  | 3.6  | /    |      | $V_{GS}=-5V, I_{SD}=10A, T_J=175^{\circ}\text{C}$ |             |
| $I_S$     | Continuous Diode Forward Current | /    | 51   | A    | $T_c=25^{\circ}\text{C}$                          |             |
| $t_{rr}$  | Reverse Recover Time             | 13   | /    | ns   | $V_R=400V, I_{SD}=10A$                            |             |
| $Q_{rr}$  | Reverse Recovery Charge          | 98   | /    | nC   |                                                   |             |
| $I_{rrm}$ | Peak Reverse Recovery Current    | 5    | /    | A    |                                                   |             |

**Thermal Characteristics**

| Symbol          | Parameter                                   | Typ. | Max. | Unit                 | Test Conditions | Note    |
|-----------------|---------------------------------------------|------|------|----------------------|-----------------|---------|
| $R_{\theta JC}$ | Thermal Resistance from Junction to Case    | 0.9  | /    | $^{\circ}\text{C/W}$ |                 | Fig. 21 |
| $R_{\theta JA}$ | Thermal Resistance from Junction to Ambient | /    | 40   |                      |                 |         |

## Typical Performance

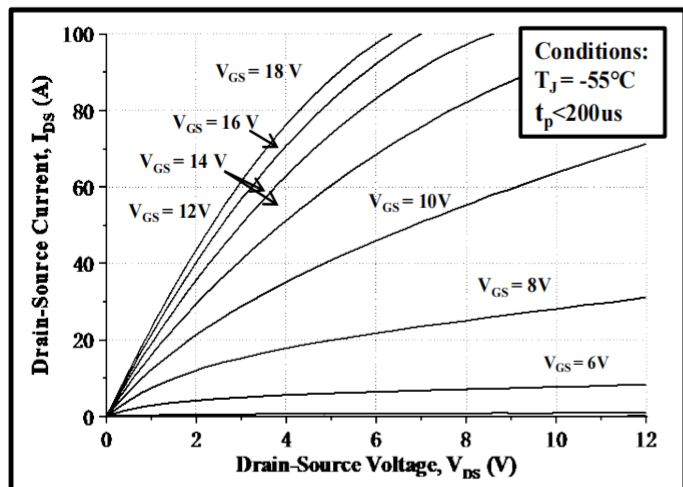


Figure 1. Output Characteristics  $T_j = -55^\circ\text{C}$

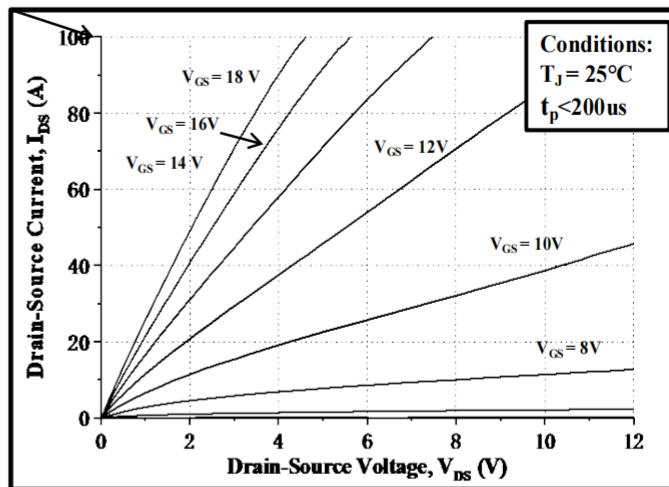


Figure 2. Output Characteristics  $T_j = 25^\circ\text{C}$

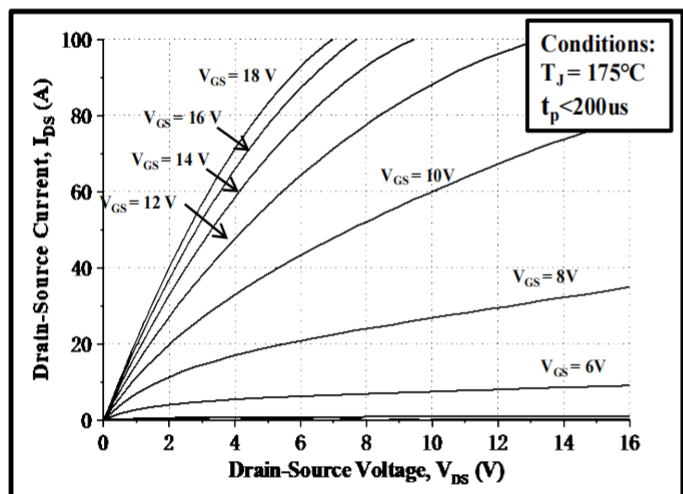


Figure 3. Output Characteristics  $T_j = 175^\circ\text{C}$

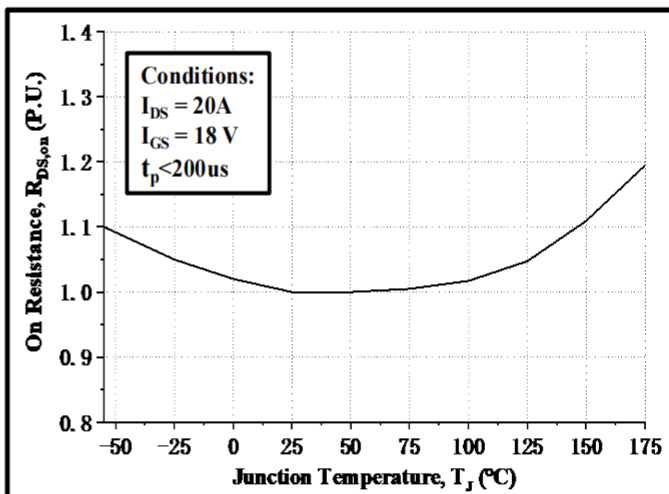


Figure 4. Normalized On-Resistance vs. Temperature

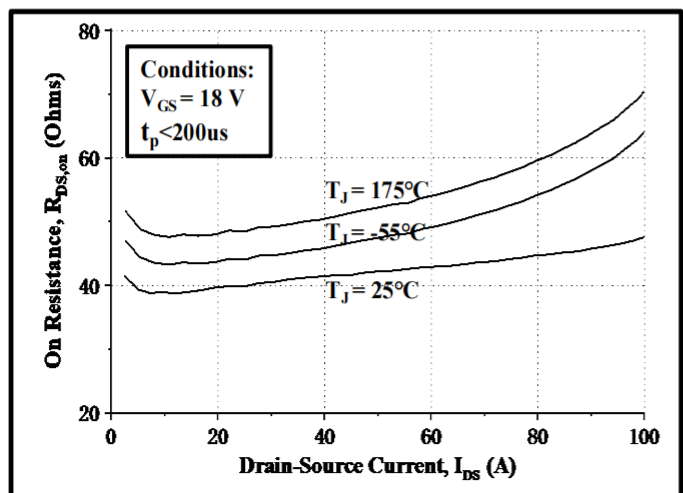


Figure 5. On-Resistance vs. Drain Current  
For Various Temperatures

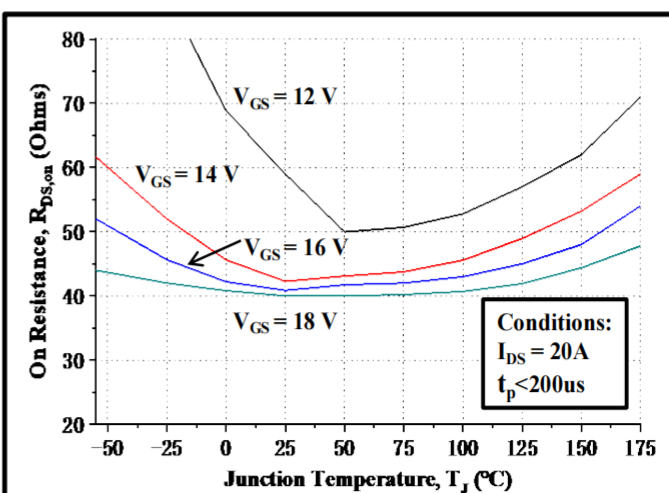


Figure 6. On-Resistance vs. Temperature  
For Various Gate Voltage

## Typical Performance

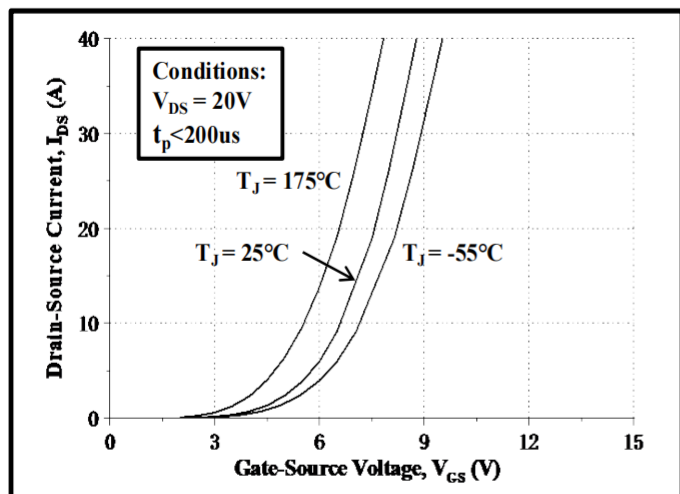


Figure 7. Transfer Characteristic for Various Junction Temperatures

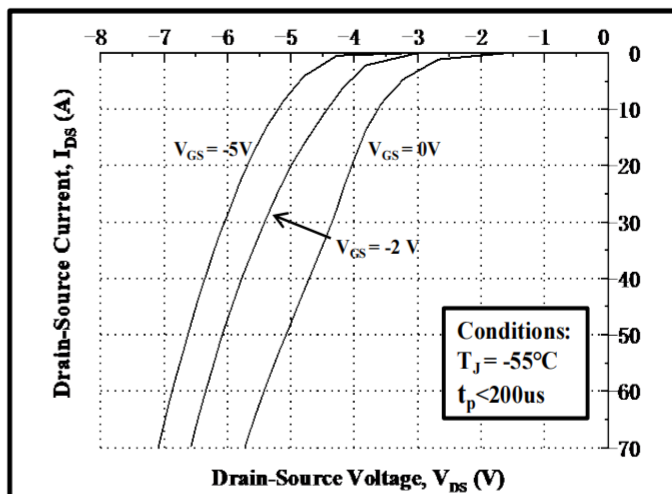


Figure 8. Body Diode Characteristic at  $-55^\circ\text{C}$

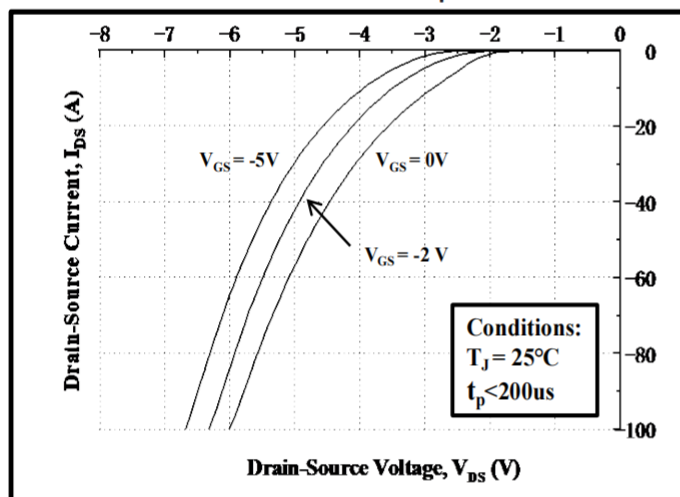


Figure 9. Body Diode Characteristic at  $25^\circ\text{C}$

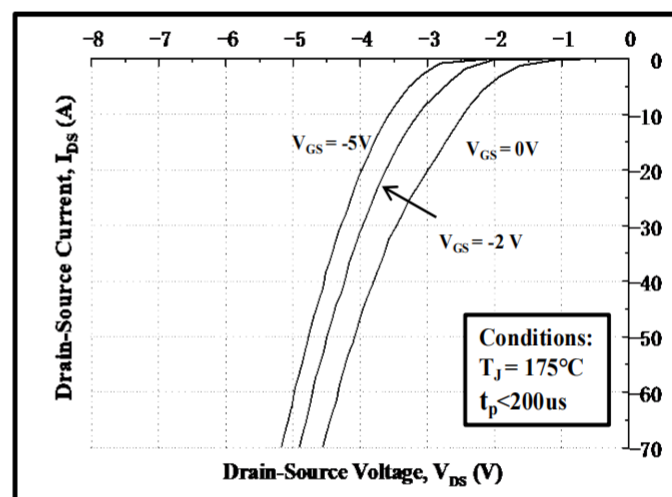


Figure 10. Body Diode Characteristic at  $175^\circ\text{C}$

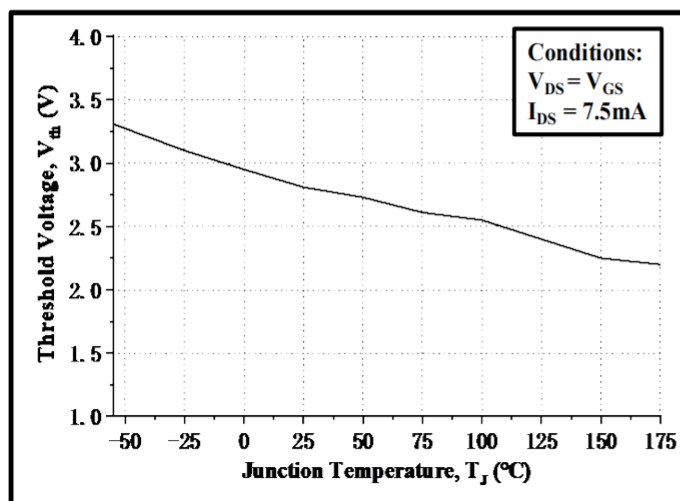


Figure 11. Threshold Voltage vs. Temperature

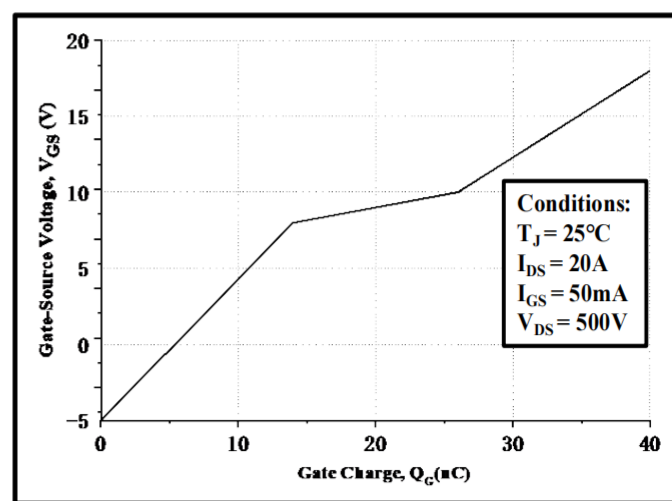


Figure 12. Gate Charge Characteristics

## Typical Performance

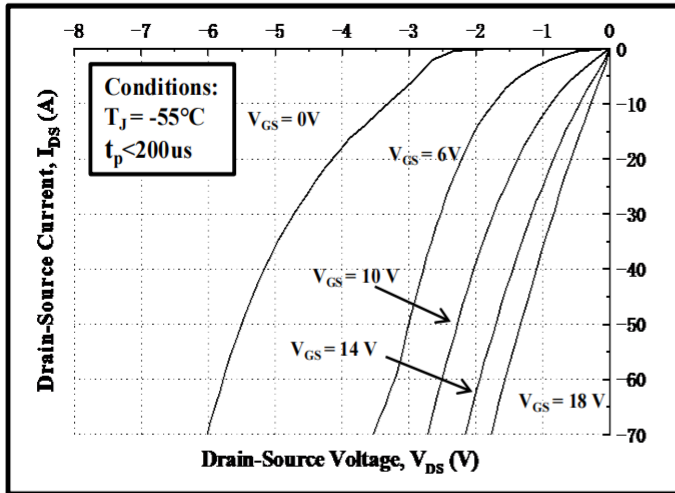


Figure 13. 3rd Quadrant Characteristic at  $-55^\circ\text{C}$

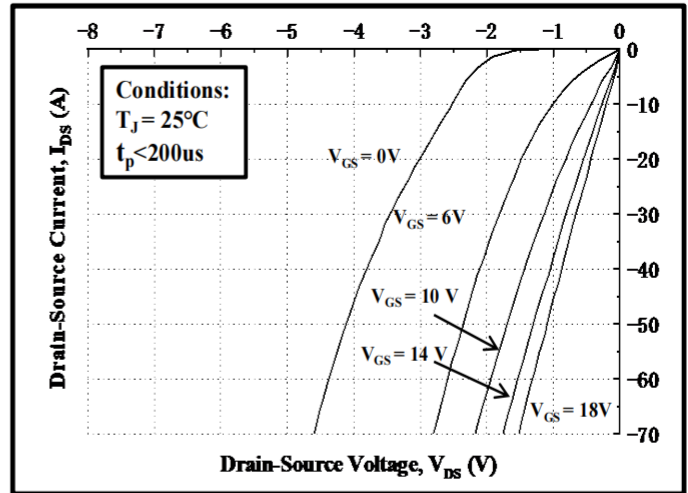


Figure 14. 3rd Quadrant Characteristic at  $25^\circ\text{C}$

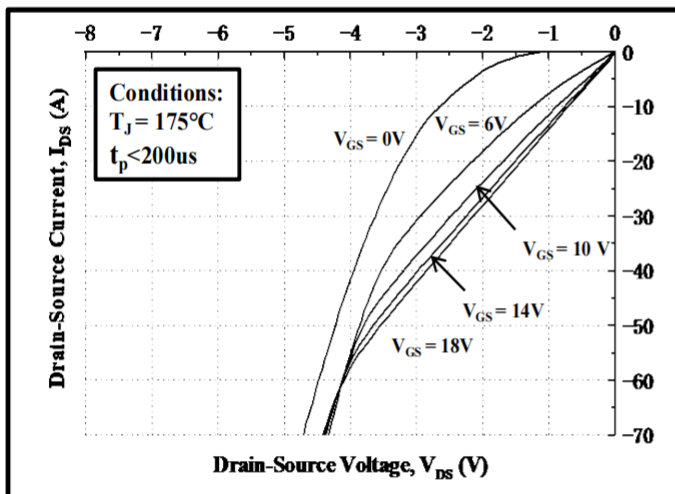


Figure 15. 3rd Quadrant Characteristic at  $175^\circ\text{C}$

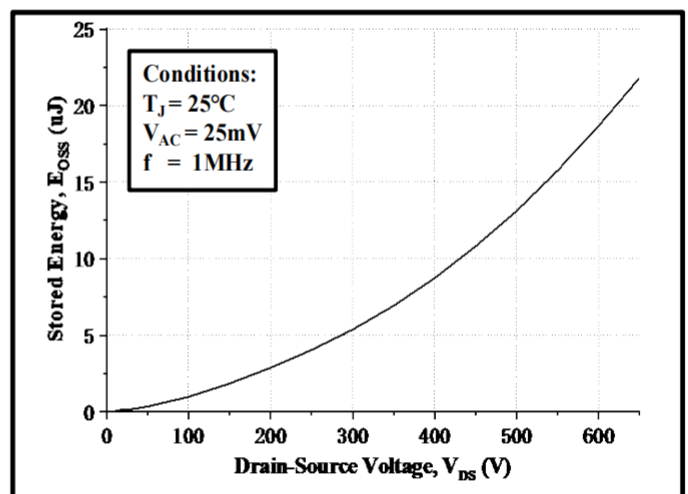


Figure 16. Output Capacitor Stored Energy

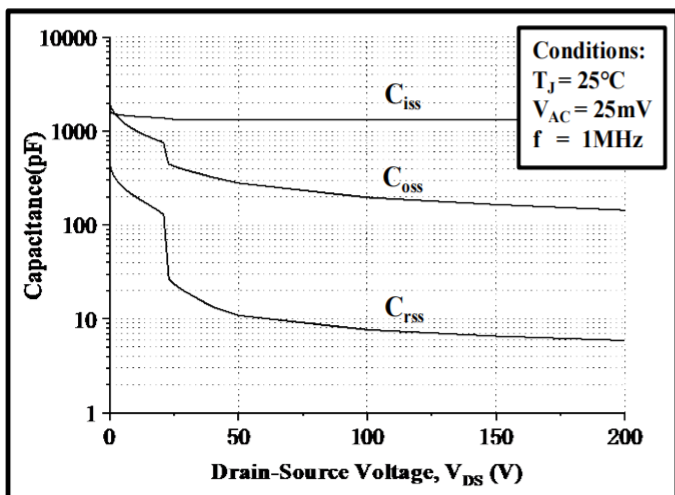


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200V)

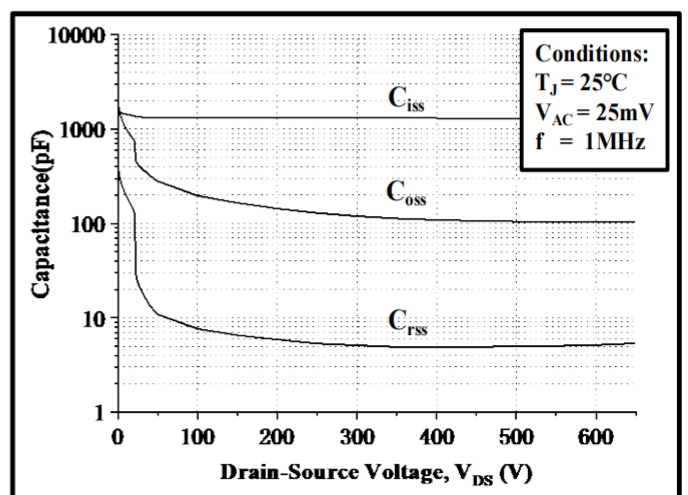


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 650V)

## Typical Performance

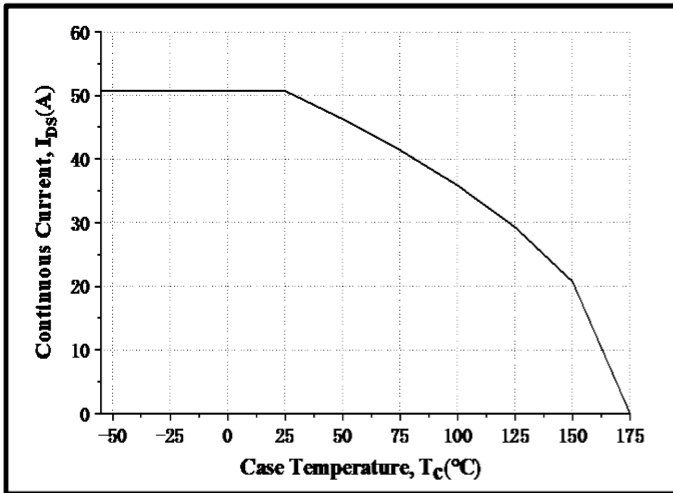


Figure 19. Continuous Drain Current Derating vs. Case Temperature

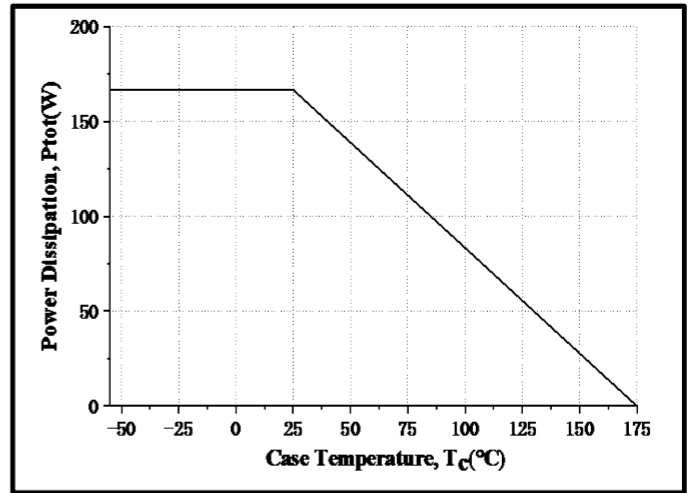


Figure 20. Maximum Power Dissipation Derating vs. Case Temperature

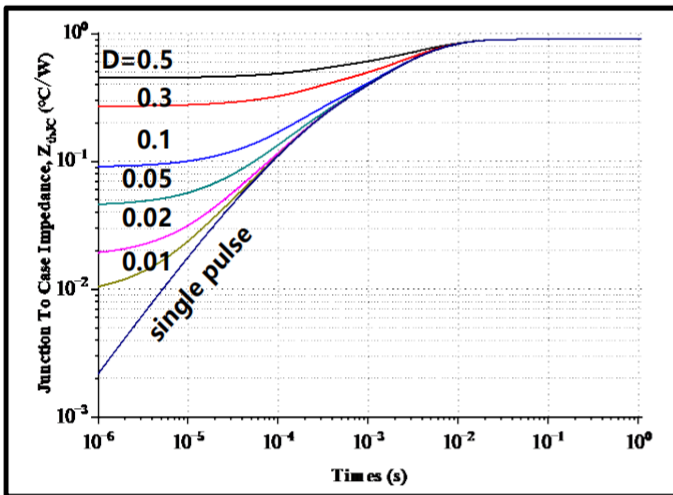


Figure 21. Transient Thermal Impedance (Junction - Case)

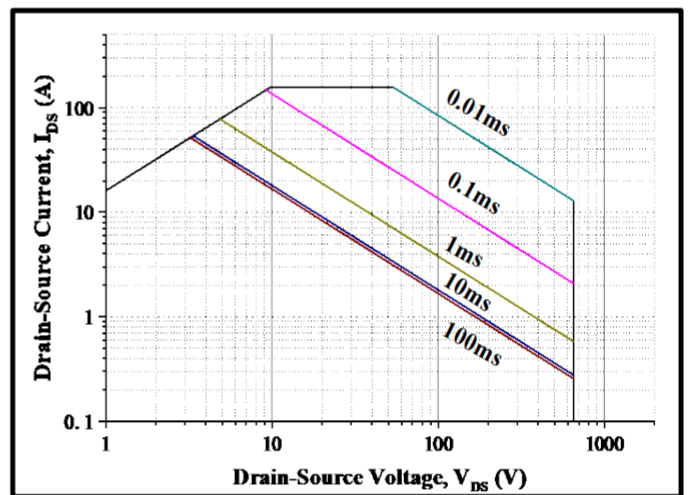


Figure 22. Safe Operating Area

**Test Circuit Schematic**

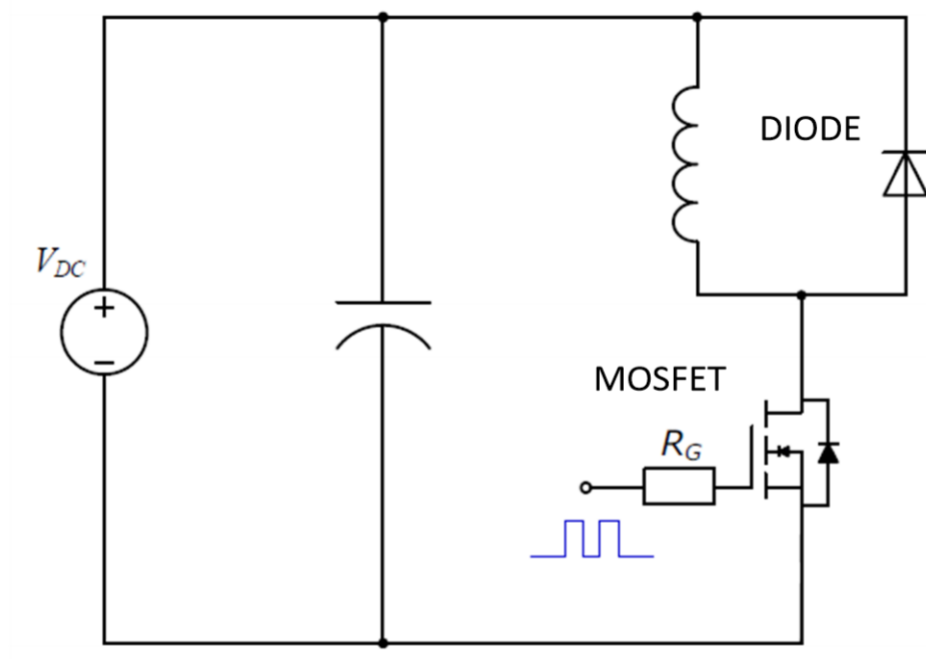
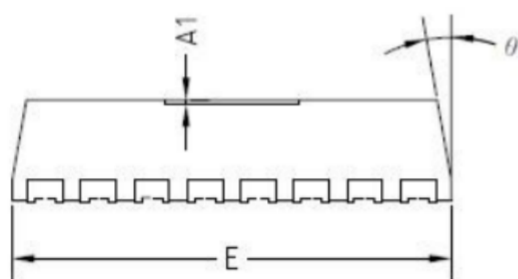
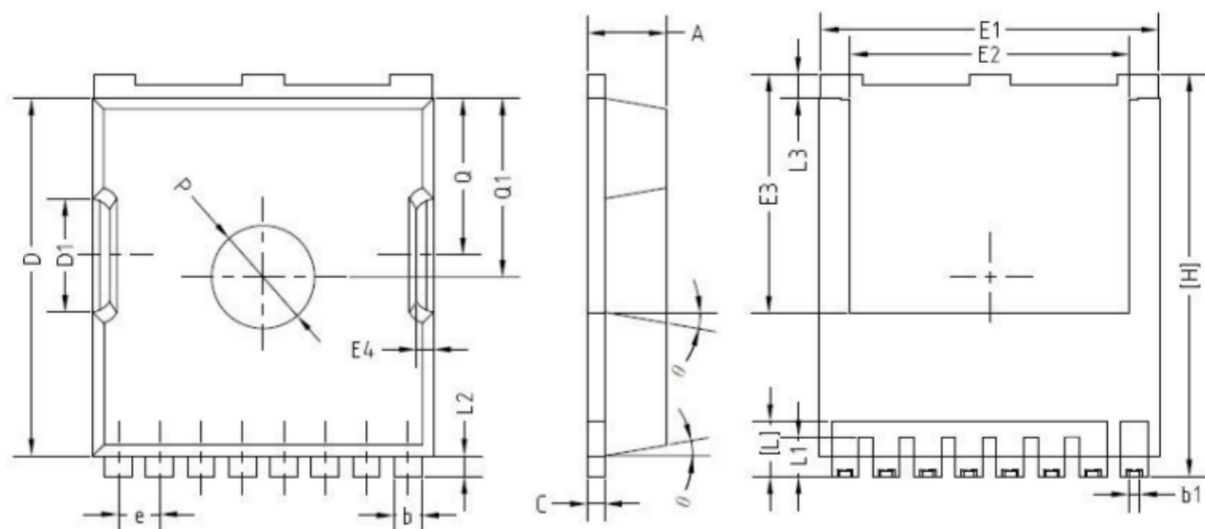


Figure 23. Clamped Inductive Switching  
Waveform Test Circuit

## Package Dimensions

### TOLL



| COMMON DIMENSIONS |             |       |       |
|-------------------|-------------|-------|-------|
| DIM               | MILLIMETERS |       |       |
|                   | MIN         | NOR   | MAX   |
| A                 | 2.20        | 2.30  | 2.40  |
| A1                | 0.05        | 0.10  | 0.15  |
| b                 | 0.70        | 0.80  | 0.90  |
| b1                | 0.35        | 0.40  | 0.45  |
| C                 | 0.40        | 0.50  | 0.65  |
| D                 | 10.40       | 10.55 | 10.70 |
| D1                | 3.20        | 3.30  | 3.40  |
| E                 | 9.80        | 9.90  | 10.00 |
| E1                | 9.70        | 9.80  | 9.90  |
| E2                | 7.95        | 8.10  | 8.25  |
| E3                | 6.80        | 7.0   | 7.20  |
| E4                | 0.30        | 0.50  | 0.75  |
| e                 | 1.15        | 1.20  | 1.25  |
| L                 | 1.40        | 1.60  | 1.80  |
| L1                | 1.05        | 1.20  | 1.35  |
| L2                | 0.50        | 0.60  | 0.70  |
| L3                | 0.60        | 0.70  | 0.80  |
| $\theta$          | 8°          | 10°   | 12°   |
| P                 | 2.90        | 3.00  | 3.10  |
| Q                 | 4.50        | 4.60  | 4.70  |
| Q1                | 5.10        | 5.20  | 5.30  |
| H                 | 11.55       | 11.70 | 11.90 |

### Notes

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